## Notice of References Cited Application/Control No. 10/579,932 Examiner Derek S. Chapel Application/Control No. 10/579,932 Applicant(s)/Patent Under Reexamination HIKMET ET AL. Page 1 of 1

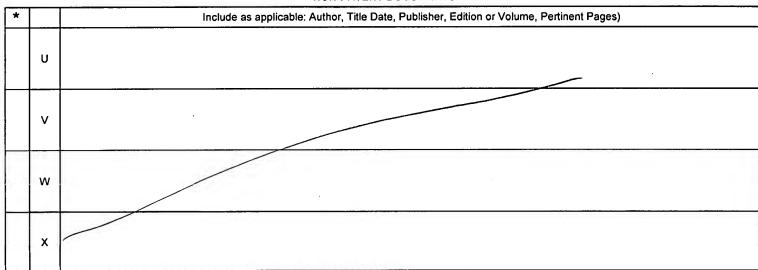
## U.S. PATENT DOCUMENTS

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## FOREIGN PATENT DOCUMENTS

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